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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,860	EICH ET AL.	
Examiner	Art Unit	Τ
Christine M. Behncke	3661	

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	DATE	EXMR
EAST Text Search Please see Attached	8/2/2005	СМВ
477/76, 78, 74, 86, 174, 70 and "curve"	8/2/2005	СМВ
192/3.58, 31 and "curve"	8/2/2005	СМВ
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